SRI LANKA STANDARD

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SAMPLING PROCEDURES FOR INSPECTION BY VARIABLES

PART 1: SPECIFICATION FOR SINGLE SAMPLING PLANS INDEXED BY ACCEPTANCE QUALITY LIMIT (AQL) FOR LOT-BY-LOT INSPECTION FOR A SINGLE QUALITY CHARACTERISTIC AND A SINGLE AQL

SRI LANKA STANDARDS INSTITUTION

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Sri Lanka Standard SAMPLING PROCEDURES FOR INSPECTION BY VARIABLES – PART 1: SPECIFICATION FOR SINGLE SAMPLING PLANS INDEXED BY ACCEPTANCE QUALITY LIMIT (AQL) FOR LOT-BY-LOT INSPECTION FOR A SINGLE QUALITY CHARACTERISTIC AND A SINGLE AQL

NATIONAL FOREWORD

This standard was approved by the Sectoral Committee on Building and Construction Materials and was authorized for adoption and publication as a Sri Lanka Standard by the Council of the Sri Lanka Standard Institution on 2016-07-22.

This Sri Lanka Standard is identical with **ISO 3951-1: 2013**, published by the International Organization for Standardization (**ISO**).

This Sri Lanka standard specifies an acceptance sampling system of single sampling plans for inspection by variables. It is indexed in terms of the acceptance quality limit (AQL).

TERMINOLOGY AND CONVENTIONS

The text of the International Standard has been accepted as suitable for publication as a Sri Lanka Standard. However, certain terminology and conventions are not identical with those used in Sri Lanka Standards.

Attention is therefore drawn to the following:

- a) Wherever the "International Standard" appear referring to this standard they should be interpreted as "Sri Lanka Standard".
- b) Wherever page numbers are quoted, they are "**ISO**" page numbers.
- c) The coma has been used throughout as a decimal marker. In Sri Lanka Standards it is the current practice to use a full point on the base line as the decimal marker.

For the purpose of deciding whether a particular requirement of this standard is complied with, the final value, observed or calculated, expressing the result of a test method or observation shall be rounded off in accordance with **SLS 102**. The number of significant places retained in the rounded off value shall be the same as that of the specified value in this standard.

CROSS REFERENCES

International Standard

ISO 2859-1: Sampling procedures for inspection by attributes -- Part 1: Sampling schemes indexed by acceptance quality limit (AQL) for lot-by-lot inspection

Corresponding Sri Lanka Standard

SLS ISO 2859-1 : Sampling procedures for inspection by attributes -- Part 1 : Sampling schemes indexed by acceptance quality limit (AQL) for lot-by-lot inspection

INTERNATIONAL STANDARD

SLS ISO 3951-1:2016 **ISO 3951-1**

Second edition 2013-09-01

Sampling procedures for inspection by variables —

Part 1:

Specification for single sampling plans indexed by acceptance quality limit (AQL) for lot-by-lot inspection for a single quality characteristic and a single AQL

Règles d'échantillonnage pour les contrôles par mesures —

Partie 1: Spécification pour les plans d'échantillonnage simples indexés par un niveau de qualité acceptable (NQA) pour un contrôle lot par lot pour une caractéristique de qualité unique et un NQA unique



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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO shall not be held responsible for identifying any or all such patent rights. Details of any patent rights identified during the development of the document will be in the Introduction and/or on the ISO list of patent declarations received (see www.iso.org/patents).

Any trade name used in this document is information given for the convenience of users and does not constitute an endorsement.

For an explanation on the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the WTO principles in the Technical Barriers to Trade (TBT) see the following URL: Foreword - Supplementary information

The committee responsible for this document is ISO/TC 69, *Application of statistical methods*, SC 5, *Acceptance sampling*.

This second edition cancels and replaces the first edition (ISO 3951-1:2006), of which it constitutes a minor revision with the following changes:

- procedures have been introduced to accommodate measurement uncertainty;
- many of the sampling plans have been adjusted to improve the match between their operating characteristic curves and the operating characteristic curves of the corresponding plans for single sampling by attributes in ISO 2859-1.

ISO 3951 consists of the following parts, under the general title *Sampling procedures for inspection by variables*:

- Part 1: Specification for single sampling plans indexed by acceptance quality limit (AQL) for lot-by-lot inspection for a single quality characteristic and a single AQL
- Part 2: General specification for single sampling plans indexed by acceptance quality limit (AQL) for lot-by-lot inspection of independent quality characteristics
- Part 3: Double sampling schemes indexed by acceptance quality limit (AQL) for lot-by-lot inspection
- Part 4: Procedures for assessment of declared quality levels
- Part 5: Sequential sampling plans indexed by acceptance quality limit (AQL) for inspection by variables (known standard deviation)